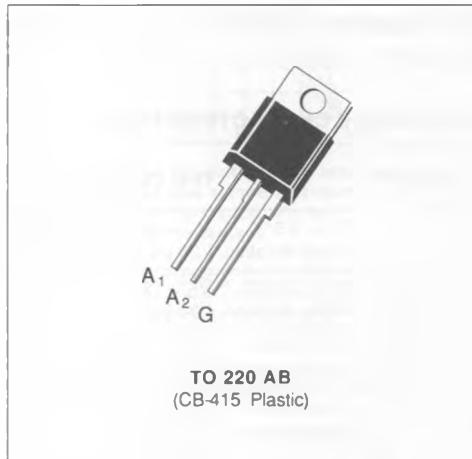


SNUBBERLESS TRIACS

- $I_{TRMS} = 8 \text{ A}$ at $T_c = 95^\circ\text{C}$.
- $V_{DRM} : 200 \text{ V}$ to 800 V .
- $I_{GT} = 35 \text{ mA}$ (QI-II-III).
- GLASS PASSIVATED CHIP.
- HIGH SURGE CURRENT : $I_{TSM} = 80 \text{ A}$.
- HIGH COMMUTATION CAPABILITY : $(di/dt)_c > 4.5 \text{ A / ms}$ without snubber.



DESCRIPTION

New range suited for applications such as phase control and static switching on inductive or resistive load.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
I_{TRMS}	RMS on-state current (360 ° conduction angle)	$T_c = 95^\circ\text{C}$	8	A
I_{TSM}	Non repetitive surge peak on-state current (T_j initial = 25 °C)	$t = 8.3 \text{ ms}$	85	A
		$t = 10 \text{ ms}$	80	
I^2t	I^2t value	$t = 10 \text{ ms}$	32	A^2s
di/dt	Critical rate of rise of on-state current (1)	Repetitive $F = 50 \text{ Hz}$	20	$\text{A}/\mu\text{s}$
		Non Repetitive	100	
T_{Jst}	Storage and operating junction temperature range	- 40, + 150 - 40, + 125		°C

Symbol	Parameter	BTB 08-					Unit
		200 CW	400 CW	600 CW	700 CW	800 CW	
V_{DRM}	Repetitive peak off-state voltage (2)	± 200	± 400	± 600	± 700	± 800	V

(1) Gate supply : $I_G = 350 \text{ mA}$ - $di/dt = 1 \text{ A / } \mu\text{s}$.

(2) $T_J = 125^\circ\text{C}$.

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-a)}$	Junction to ambient	60	°C/W
$R_{th(j-c)}$ DC	Junction to case for DC	3.5	°C/W
$R_{th(j-c)}$ AC	Junction to case for 360 ° conduction angle ($F = 50$ Hz)	2.7	°C/W

GATE CHARACTERISTICS (maximum values)

$P_{GM} = 40$ W ($t = 10$ μ s) $P_{G(AV)} = 1$ W $I_{GM} = 4$ A ($t = 10$ μ s) $V_{GM} = 16$ V ($t = 10$ μ s).

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions		Quadrants	Min.	Typ.	Max.	Unit
I_{GT}	$T_j = 25$ °C	$V_D = 12$ V	$R_L = 33 \Omega$	I-II-III	1	35	mA
	Pulse duration > 20 μ s					1.5	V
V_{GT}	$T_j = 25$ °C	$V_D = 12$ V	$R_L = 33 \Omega$	I-II-III			
	Pulse duration > 20 μ s					0.2	V
V_{GD}	$T_j = 125$ °C	$V_D = V_{DRM}$	$R_L = 3.3$ k Ω	I-II-III			
	Pulse duration > 20 μ s						
I_H *	$T_j = 25$ °C Gate open	$I_T = 100$ mA	$R_L = 140 \Omega$			35	mA
I_{L_s}	$T_j = 25$ °C	$V_D = 12$ V	$I_G = 350$ mA	I-III		50	mA
	Pulse duration > 20 μ s			II		80	
V_{TM} *	$T_j = 25$ °C	$I_{TM} = 11$ A	$t_p = 10$ ms			1.75	V
I_{DRM} *	$T_j = 25$ °C $T_j = 125$ °C	V_{DRM} rated	Gate open			0.01	mA
						2	
dV/dt *	$T_j = 125$ °C Linear slope up to 0.67 V_{DRM}	Gate open			250	500	V/ μ s
$(di/dt)_c$ *	$T_j = 125$ °C Without snubber	V_{DRM} rated			4.5	9	A/ms
t_{gt}	$T_j = 25$ °C $I_T = 11$ A	$di_G/dt = 1$ A/ μ s	$I_G = 350$ mA	I-II-III		2	μ s

* For either polarity of electrode A₂ voltage with reference to electrode A₁.

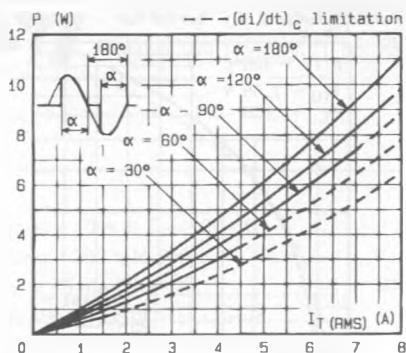


Fig.1 - Maximum mean power dissipation versus RMS on-state current ($f = 60$ Hz).

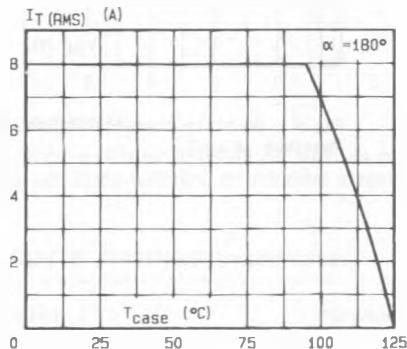


Fig.3 - RMS on-state current versus case temperature.

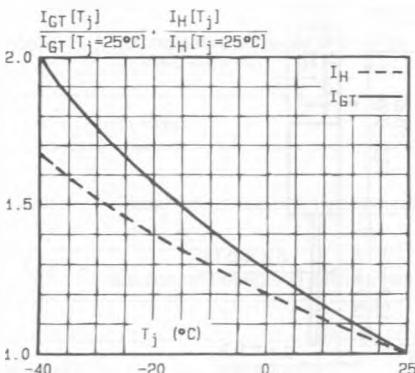


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

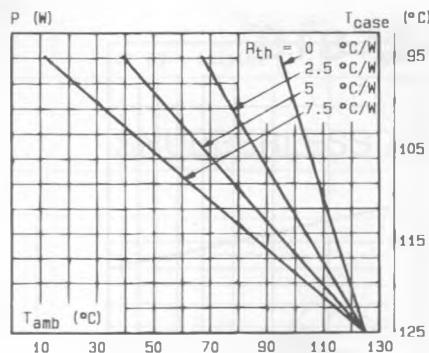


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

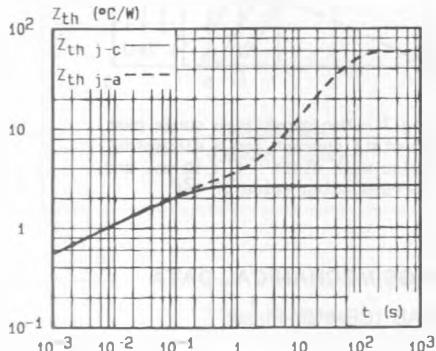


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

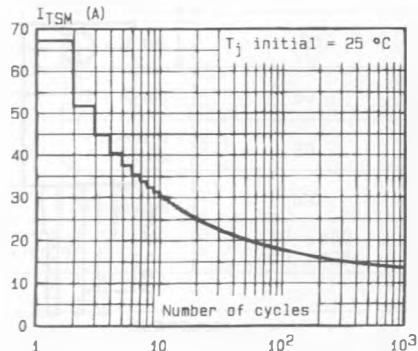


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.

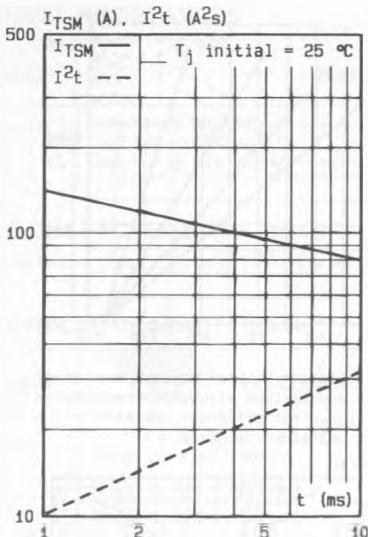


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \leq 10$ ms. and corresponding value of I^2t .

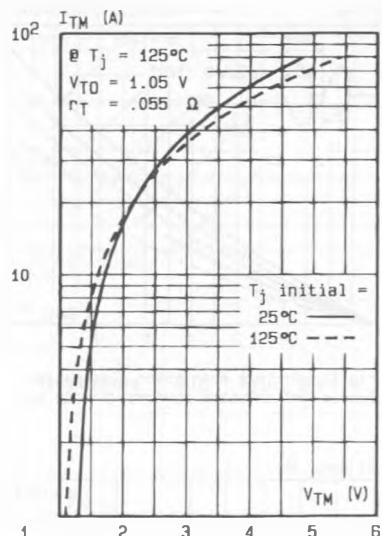
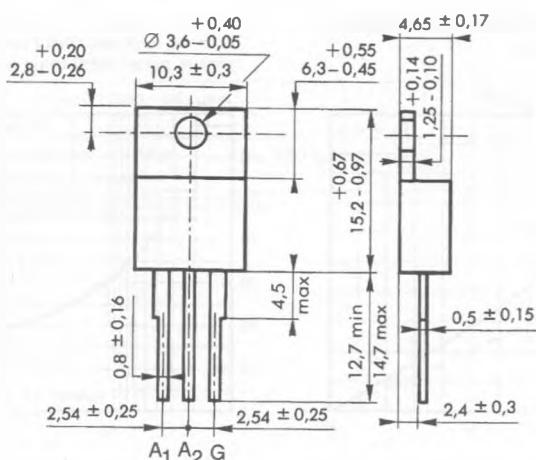


Fig.8 - On-state characteristics (maximum values).

PACKAGE MECHANICAL DATA

TO 220 AB (CB-415) Plastic



Cooling method : by conduction (method C)

Marking : type number

Weight : 2 g